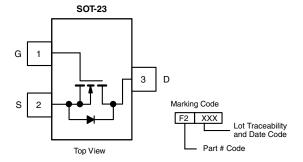


Vishay Siliconix

N-Channel 8 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^{a, e}	Q _g (Typ.)		
8	0.017 at V _{GS} = 4.5 V	6			
	0.020 at V _{GS} = 2.5 V	6			
	0.022 at V _{GS} = 1.8 V	6	6 nC		
	0.030 at V _{GS} = 1.5 V	6			
	0.075 at V _{GS} = 1.2 V	6			



Ordering Information: Si2342DS-T1-GE3 (Lead (Pb)-free and Halogen-free)

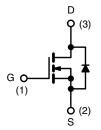
FEATURES

- Halogen-free According to IEC 61249-2-21 **Definition**
- TrenchFET® Power MOSFET
- Low On-Resistance
- 100 % R_g Tested
- Compliant to RoHS Directive 2002/95/EC

HALOGEN FREE

APPLICATIONS

- Load Switches for Low Voltage Gate Drive
- Low Voltage Operating Circuits
 - Gate Drive 1.2 V to 5 V



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)					
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	8	V	
Gate-Source Voltage		V _{GS}	± 5	v	
	T _C = 25 °C		6 ^e		
Continuous Drain Current (T. 150 °C)	T _C = 70 °C	1 .	6 ^e		
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	- I _D	6 ^{e, b, c}		
	T _A = 70 °C		5.8 ^{b, c}	Α	
Pulsed Drain Current (t = 300 μs)		I _{DM}	30		
Continuous Source-Drain Diode Current	T _C = 25 °C		2.1		
Continuous Source-Drain Diode Current	T _A = 25 °C	- I _S	1.1 ^{b, c}		
Maximum Power Dissipation	T _C = 25 °C		2.5		
	T _C = 70 °C	P _D	1.6	w	
	T _A = 25 °C		1.3 ^{b, c}	- vv	
	T _A = 70 °C		0.8 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	- °C	
Soldering Recommendations (Peak Temperature)		_	260		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 5 s	R _{thJA}	75	100	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	40	50		

Notes:

- a. Based on $T_C = 25$ °C.
- b. Surface mounted on 1" x 1" FR4 board.
- d. Maximum under steady state conditions is 166 °C/W.
- e. Package limited.

Si2342DS

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static				•	•	'	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, } I_D = 250 \mu\text{A}$	8			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L = 250 HA		10		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	$I_{D} = 250 \mu A$		- 2.5			
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	0.35		0.8	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 5 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 8 V, V _{GS} = 0 V			1	μΑ	
		V _{DS} = 8 V, V _{GS} = 0 V, T _J = 70 °C			10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	20			Α	
		$V_{GS} = 4.5 \text{ V}, I_D = 7.2 \text{ A}$		0.014	0.017	1	
		$V_{GS} = 2.5 \text{ V}, I_D = 6.7 \text{ A}$		0.016	0.020	1	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 1.8 \text{ V}, I_D = 6.4 \text{ A}$		0.018	0.022	Ω	
		$V_{GS} = 1.5 \text{ V}, I_D = 5.5 \text{ A}$		0.020	0.030		
		$V_{GS} = 1.2 \text{ V}, I_D = 1.3 \text{ A}$		0.025	0.075		
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 4 \text{ V}, I_{D} = 7.2 \text{ A}$		75		S	
Dynamic ^b	<u>'</u>			•	•	,	
Input Capacitance	C _{iss}			1070		pF	
Output Capacitance	C _{oss}	$V_{DS} = 4 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		385			
Reverse Transfer Capacitance	C _{rss}			200			
·		$V_{DS} = 4 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 7.2 \text{ A}$		10.5	15.8		
Total Gate Charge	Q_g			6	9		
Gate-Source Charge	Q_{gs}	$V_{DS} = 4 \text{ V}, V_{GS} = 2.5 \text{ V}, I_{D} = 7.2 \text{ A}$		1.6		nC	
Gate-Drain Charge	Q_{gd}			1			
Gate Resistance	R_{g}	f = 1 MHz	2.4	12	24	Ω	
Turn-On Delay Time	t _{d(on)}			6	12		
Rise Time	t _r	$V_{DD} = 4 \text{ V}, R_L = 0.7 \Omega$		14	20	ns	
Turn-Off Delay Time	t _{d(off)}	$I_D\cong 5.8$ A, V_{GEN} = 4.5 V, R_g = 1 Ω		65	98		
Fall Time	t _f			25	38		
Drain-Source Body Diode Characteristi	cs			l .		L	
Continuous Source-Drain Diode Current	Is	T _C = 25 °C			2.1	_	
Pulse Diode Forward Current	I _{SM}				30	A	
Body Diode Voltage	V _{SD}	$I_S = 5.8 \text{ A}, V_{GS} = 0$		0.82	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			40	60	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	L EQA di/dt 100 A/ T 05 00		17	26	nC	
Reverse Recovery Fall Time	t _a	$I_F = 5.8 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		15			
Reverse Recovery Rise Time		t _b		25		ns	

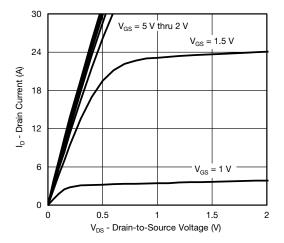
- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

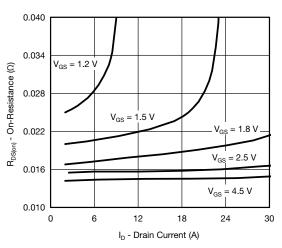


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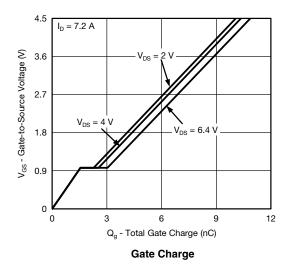
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

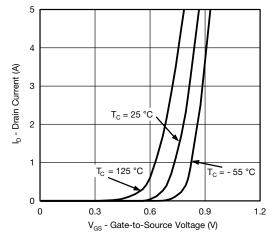


Output Characteristics

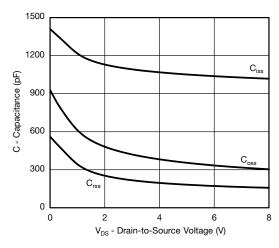


On-Resistance vs. Drain Current and Gate Voltage

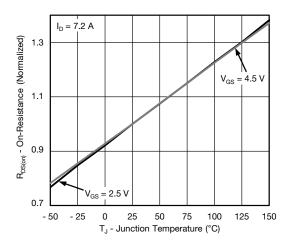




Transfer Characteristics



Capacitance

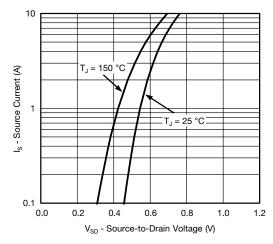


On-Resistance vs. Junction Temperature

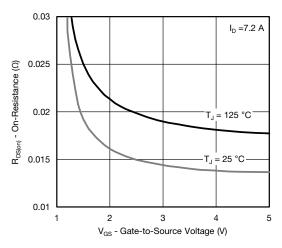
Si2342DS

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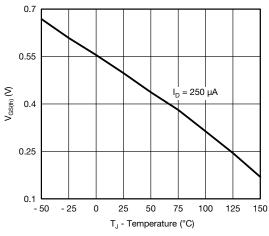
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



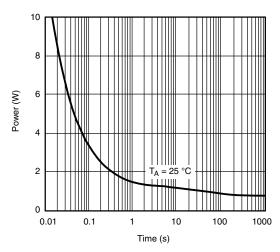
Source-Drain Diode Forward Voltage



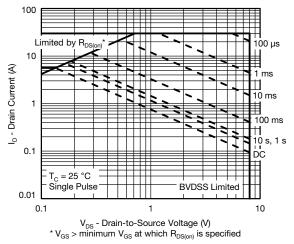
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power (Junction-to-Ambient)

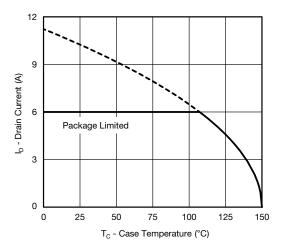


Safe Operating Area, Junction-to-Ambient

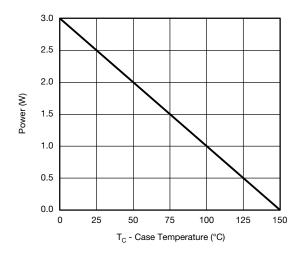


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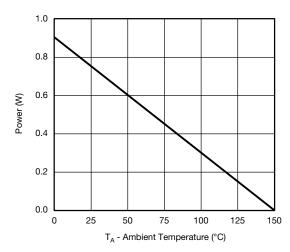
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating*







Power Derating, Junction-to-Ambient

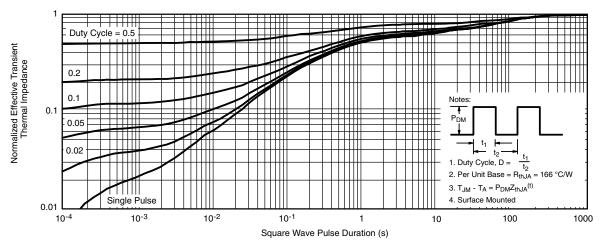
Document Number: 63302 S11-1388-Rev. A, 11-Jul-11

 $^{^{\}star}$ The power dissipation P_D is based on $T_{J(max.)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heats inking is used. It is used to determine the current rating, when this rating falls below the package limit.

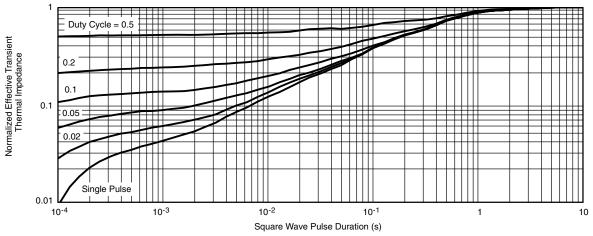
Si2342DS

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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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Revision: 11-Mar-11